

Bibliography on applications of Magnetic Force Microscopy

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2634**Calibration of magnetic force microscopy tips by using nanoscale current-carrying parallel wires**

Th. Kebe and A. Carl

J. Appl. Phys., 95 (2004) 3, 775-792**2696****Magnetic versus structural properties of Co nanocluster thin films: A magnetic force microscopy study**

S. A. Koch, R. H. te Velde, G. Palasantzas, and J. Th. M. De Hosson

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